



N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	I _D T _A = 25°C
60V	2Ω @ V _{GS} = 10V	540mA
OOV	3Ω @ V _{GS} = 5V	430mA

Description and Applications

This new generation MOSFET has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

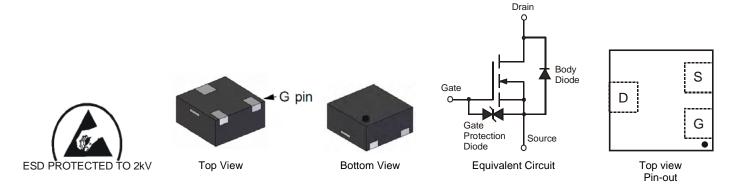
- DC-DC Converters
- Power management functions
- Battery Operated Systems and Solid-State Relays
- Load switch

Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- ESD Protected Gate to 2kV
- Lead Free/RoHS Compliant (Note 1)
- Green Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: X1-DFN1212-3
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Solderable per MIL-STD-202, Method 208
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Terminal Connections: See Diagram
- Weight: 0.005 grams (approximate)



Ordering Information (Note 3)

Part Number	Case	Packaging		
DMN62D0SFD-7	X1-DFN1212-3	3000/Tape & Reel		

Notes:

- 1. No purposefully added lead.
- 2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com
- 3. For packaging details, go to our website at http://www.diodes.com

Marking Information



K62 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011) M = Month (ex: 9 = September)

Date Code Key

Year	20	07	20	08	20	09	20	10	20	11	20	12
Code	l	J	\	V	V	V)	Χ	`	1	Z	7
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	60	V		
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Current (Note EV)	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	540 430	mA
Continuous Drain Current (Note 5) V _{GS} = 10V	t<10s	$T_A = 25$ °C $T_A = 70$ °C	I _D	630 500	mA
Continuous Drain Current (Note 5) V	Steady State	$T_A = 25$ °C $T_A = 70$ °C	I _D	430 340	mA
Continuous Drain Current (Note 5) V _{GS} = 5V	t<10s	T _A = 25°C T _A = 70°C	I _D	510 410	mA
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	1.0	Α		
Maximum Body Diode Forward Current (Note 5)	I _S	1.0	Α		

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 4)		P_{D}	0.43	W
Thermal Desistance, Junction to Ambient (Note 4)	Steady state	Б.	260	°C/W
Thermal Resistance, Junction to Ambient (Note 4)	t<10s	$R_{\theta JA}$	182	°C/W
Total Power Dissipation (Note 5)		P_{D}	0.89	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	Б	140	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	98	°C/W
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	112	°C/W
Operating and Storage Temperature Range		$T_{J_i}T_{STG}$	-55 to +150	°C

Electrical Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	60	ı	-	V	$V_{GS} = 0V, I_{D} = 10\mu A$
Zero Gate Voltage Drain Current T _J = 25°C	I _{DSS}	-	-	100	nA	$V_{DS} = 60V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	10	μΑ	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						_
Gate Threshold Voltage	V _{GS(th)}	1.0	1.6	2.5	٧	$V_{DS} = 10V, I_{D} = 1mA$
Static Drain-Source On-Resistance	D	-	1	2	Ω	$V_{GS} = 10V, I_D = 500mA$
Static Dialif-Source Off-Resistance	R _{DS (ON)}	-	ı	3	52	$V_{GS} = 5V$, $I_D = 50mA$
Forward Transfer Admittance	Y _{fs}	-	130	-	mS	$V_{DS} = 3V, I_{D} = 30mA$
Diode Forward Voltage	V_{SD}	-	0.8	1.2	V	$V_{GS} = 0V, I_{S} = 300mA$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	C _{iss}	-	30.2	-	pF	V 05)/)/ 0)/
Output Capacitance	Coss	-	4.4	-	рF	$V_{DS} = 25V, V_{GS} = 0V,$ -f = 1.0MHz
Reverse Transfer Capacitance	Crss	-	2.8	-	pF	1 = 1.0lvii iz
Gate Resistance	Rg	-	131	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	0.39	-	nC	
Total Gate Charge (V _{GS} = 10.0V)	Qg	-	0.87	-	nC	V 40V I 4A
Gate-Source Charge	Q _{gs}	-	0.14	-	nC	$V_{DS} = 10V, I_{D} = 1A$
Gate-Drain Charge	Q_{gd}	-	0.09	-	nC	
Turn-On Delay Time	t _{D(on)}	-	3.95	-	ns	
Turn-On Rise Time	t _r	-	3.81	-	ns	$V_{DS} = 30V, I_{D} = 200mA$
Turn-Off Delay Time	t _{D(off)}	-	16.0	-	ns	$V_{GS} = 10V$, $R_G = 25 \Omega$
Turn-Off Fall Time	t _f	-	9.04	-	ns	

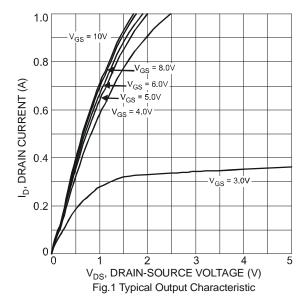
Notes: 4. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

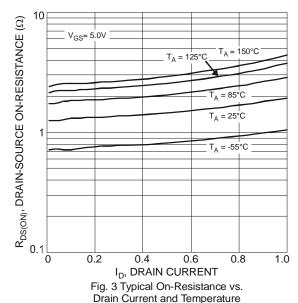
^{5.} Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate

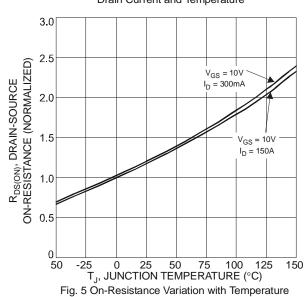
^{6 .}Short duration pulse test used to minimize self-heating effect.

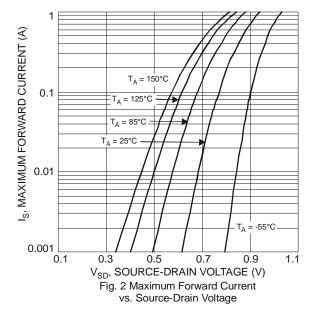
^{7.} Guaranteed by design. Not subject to production testing.











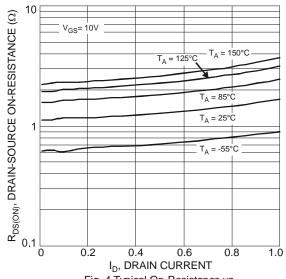


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

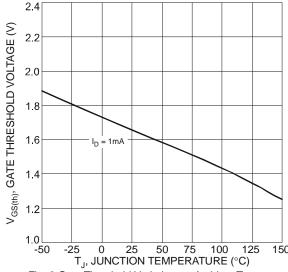
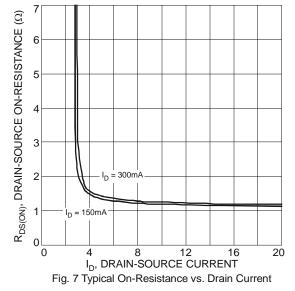
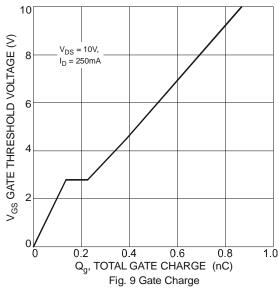


Fig. 6 Gate Threshold Variation vs. Ambient Temperature







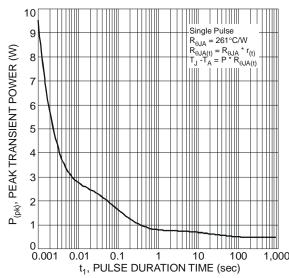
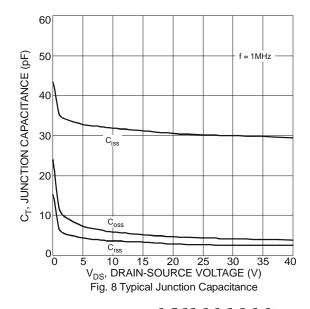
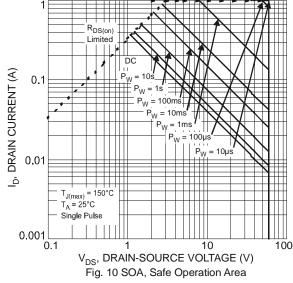
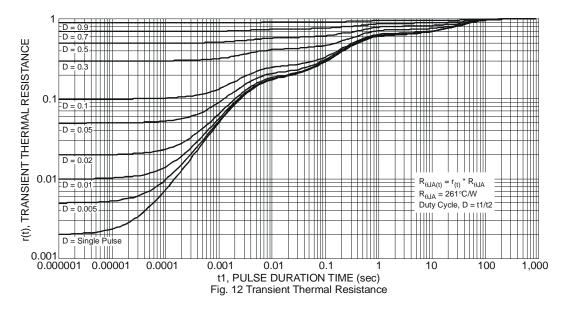


Fig. 11 Single Pulse Maximum Power Dissipation

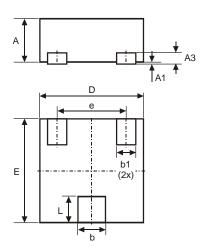






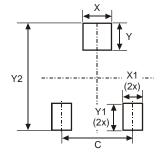


Package Outline Dimensions



X1-DFN1212-3							
Dim	Min	Max	Тур				
Α	0.47	0.53	0.50				
A 1	0	0.05	0.02				
A3	-	-	0.13				
b	0.27	0.37	0.32				
b1	0.17	0.27	0.22				
D	1.15	1.25	1.20				
Е	1.15	1.25	1.20				
е	-	-	0.80				
Ĺ	0.25	0.35	0.30				
All Dimensions in mm							

Suggested Pad Layout



Dimensions	Value (in mm)
С	0.80
Х	0.42
X1	0.32
Υ	0.50
Y1	0.50
Y2	1.50



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